

ULTRAFast SOFT RECOVERY RECTIFIER DIODE

PRODUCT APPLICATIONS

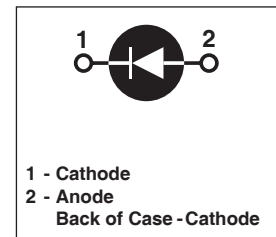
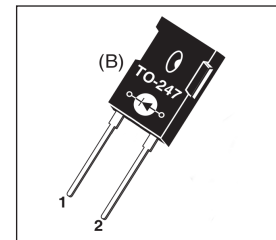
- Anti-Parallel Diode
 - Switchmode Power Supply
 - Inverters
- Free Wheeling Diode
 - Motor Controllers
 - Converters
 - Inverters
- Snubber Diode
- PFC

PRODUCT FEATURES

- Ultrafast Recovery Times
- Soft Recovery Characteristics
- Popular TO-247 Package
- Low Forward Voltage
- Low Leakage Current

PRODUCT BENEFITS

- Low Losses
- Low Noise Switching
- Cooler Operation
- Higher Reliability Systems
- Increased System Power Density



MAXIMUM RATINGS

All Ratings: $T_C = 25^\circ\text{C}$ unless otherwise specified.

| Symbol | Characteristic / Test Conditions | APT15D60BG | UNIT |
|----------------|---|------------|------------------|
| V_R | Maximum D.C. Reverse Voltage | 600 | Volts |
| V_{RRM} | Maximum Peak Repetitive Reverse Voltage | | |
| V_{RWM} | Maximum Working Peak Reverse Voltage | | |
| $I_{F(AV)}$ | Maximum Average Forward Current ($T_C = 133^\circ\text{C}$, Duty Cycle = 0.5) | 15 | Amps |
| $I_{F(RMS)}$ | RMS Forward Current (Square wave, 50% duty) | 32 | |
| I_{FSM} | Non-Repetitive Forward Surge Current ($T_J = 45^\circ\text{C}$, 8.3ms) | 110 | |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to 175 | $^\circ\text{C}$ |
| T_L | Lead Temperature for 10 Sec. | 300 | |

STATIC ELECTRICAL CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|----------|---|--|-----|-----|---------------|
| V_F | Forward Voltage | $I_F = 15\text{A}$ | | 1.6 | Volts |
| | | $I_F = 30\text{A}$ | | 1.9 | |
| | | $I_F = 15\text{A}, T_J = 125^\circ\text{C}$ | | 1.4 | |
| I_{RM} | Maximum Reverse Leakage Current | $V_R = V_R$ Rated | | 150 | μA |
| | | $V_R = V_R$ Rated, $T_J = 125^\circ\text{C}$ | | 500 | |
| C_T | Junction Capacitance, $V_R = 200\text{V}$ | | 23 | | pF |

DYNAMIC CHARACTERISTICS

APT15D60BG

| Symbol | Characteristic | Test Conditions | MIN | TYP | MAX | UNIT |
|-----------|----------------------------------|--|-----|-----|-----|------|
| t_{rr} | Reverse Recovery Time | $I_F = 1A$, $di_F/dt = -100A/\mu s$, $V_R = 30V$, $T_J = 25^\circ C$ | - | 21 | | ns |
| t_{rr} | Reverse Recovery Time | $I_F = 15A$, $di_F/dt = -200A/\mu s$ $V_R = 400V$, $T_C = 25^\circ C$ | - | 80 | | |
| Q_{rr} | Reverse Recovery Charge | | - | 95 | | nC |
| I_{RRM} | Maximum Reverse Recovery Current | | - | 3 | - | Amps |
| t_{rr} | Reverse Recovery Time | $I_F = 15A$, $di_F/dt = -200A/\mu s$ $V_R = 400V$, $T_C = 125^\circ C$ | - | 150 | | ns |
| Q_{rr} | Reverse Recovery Charge | | - | 520 | | nC |
| I_{RRM} | Maximum Reverse Recovery Current | | - | 7 | - | Amps |
| t_{rr} | Reverse Recovery Time | $I_F = 15A$, $di_F/dt = -1000A/\mu s$ $V_R = 400V$, $T_C = 125^\circ C$ | - | 60 | | ns |
| Q_{rr} | Reverse Recovery Charge | | - | 810 | | nC |
| I_{RRM} | Maximum Reverse Recovery Current | | - | 22 | | Amps |

THERMAL AND MECHANICAL CHARACTERISTICS

| Symbol | Characteristic / Test Conditions | MIN | TYP | MAX | UNIT |
|-----------------|--|-----|------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case Thermal Resistance | | | 1.35 | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient Thermal Resistance | | | 40 | |
| W_T | Package Weight | | 0.22 | | oz |
| | | | 5.9 | | g |
| Torque | Maximum Mounting Torque | | | 10 | lb•in |
| | | | | 1.1 | N•m |

APT Reserves the right to change, without notice, the specifications and information contained herein.

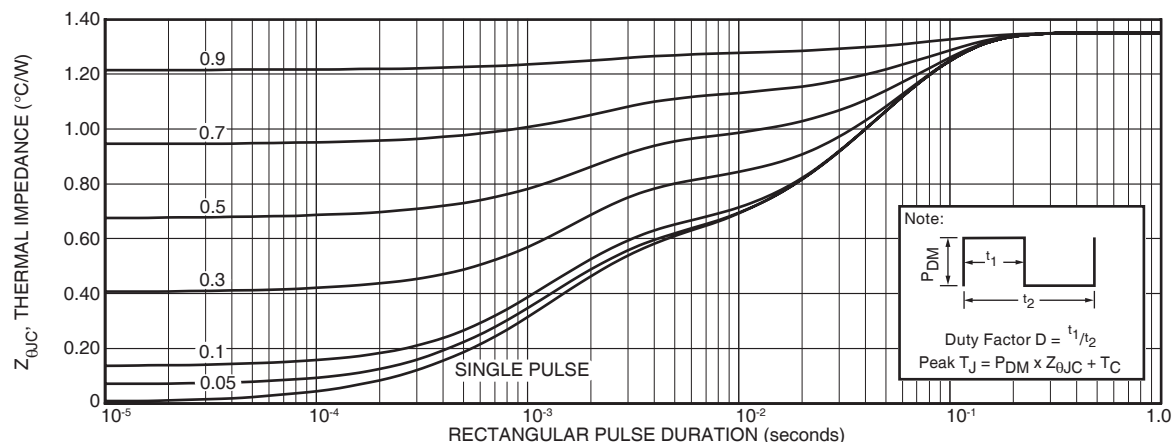


FIGURE 1a. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs. PULSE DURATION

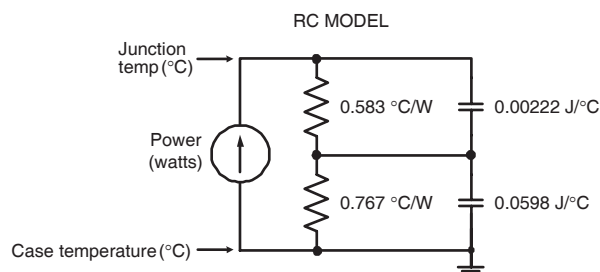


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

TYPICAL PERFORMANCE CURVES

APT15D60BG

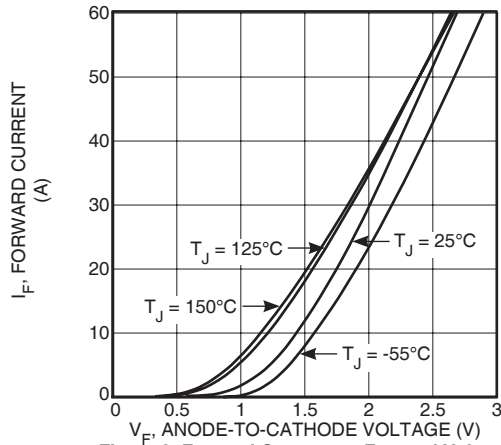


Figure 2. Forward Current vs. Forward Voltage

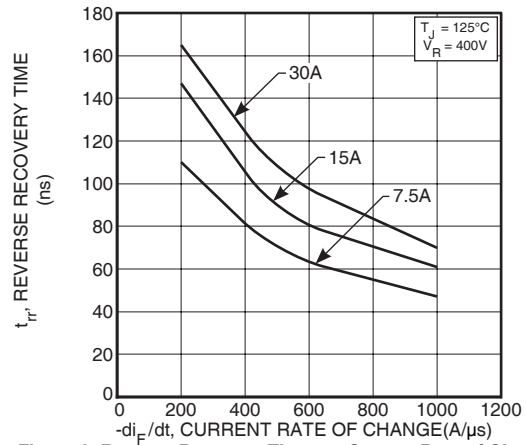


Figure 3. Reverse Recovery Time vs. Current Rate of Change

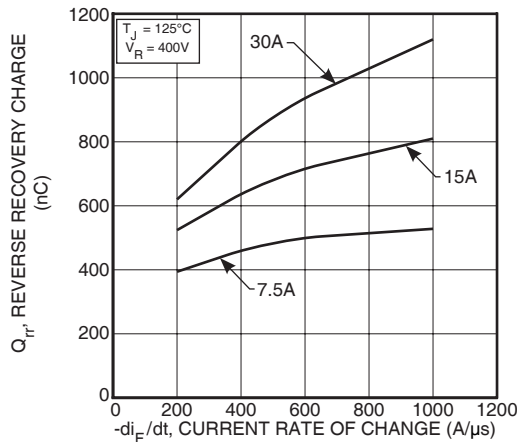


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

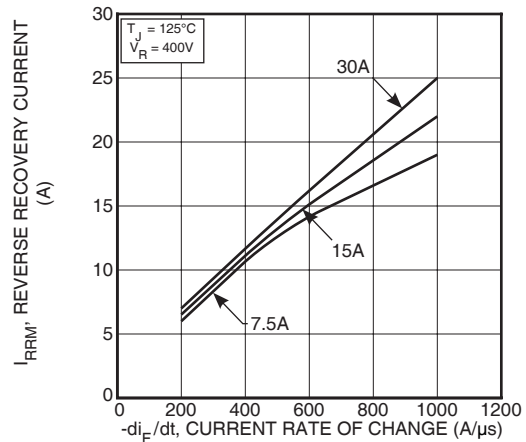


Figure 5. Reverse Recovery Current vs. Current Rate of Change

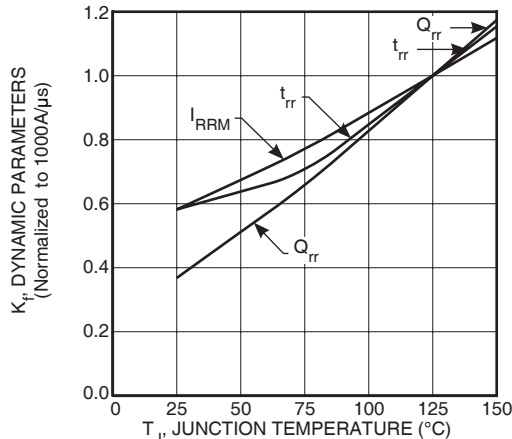


Figure 6. Dynamic Parameters vs. Junction Temperature

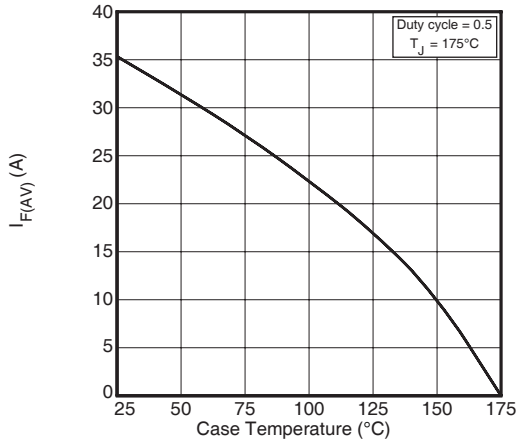


Figure 7. Maximum Average Forward Current vs. Case Temperature

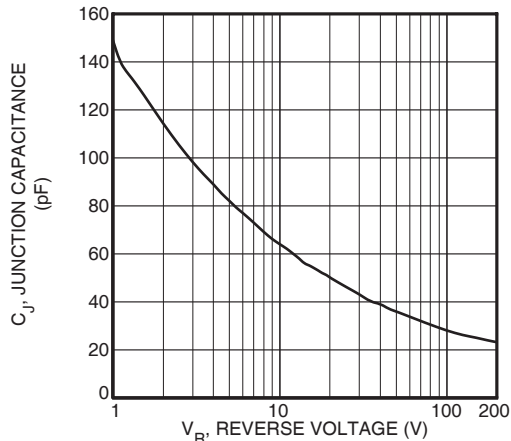


Figure 8. Junction Capacitance vs. Reverse Voltage

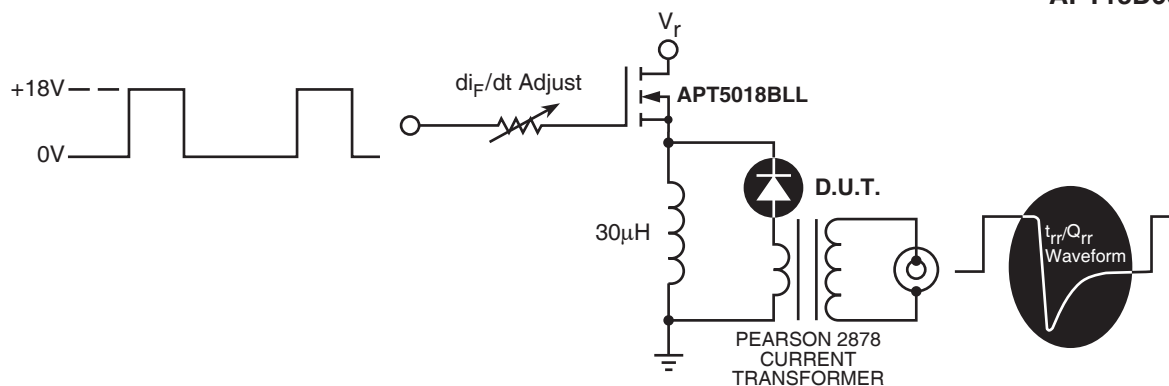


Figure 9. Diode Test Circuit

- 1 I_F - Forward Conduction Current
- 2 di_F/dt - Rate of Diode Current Change Through Zero Crossing.
- 3 I_{RRM} - Maximum Reverse Recovery Current.
- 4 t_{rr} - Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and $0.25 \cdot I_{RRM}$ passes through zero.
- 5 Q_{rr} - Area Under the Curve Defined by I_{RRM} and t_{rr} .

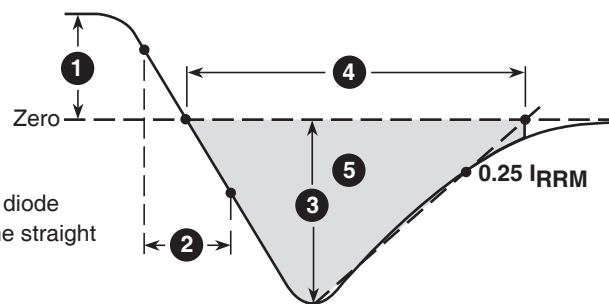
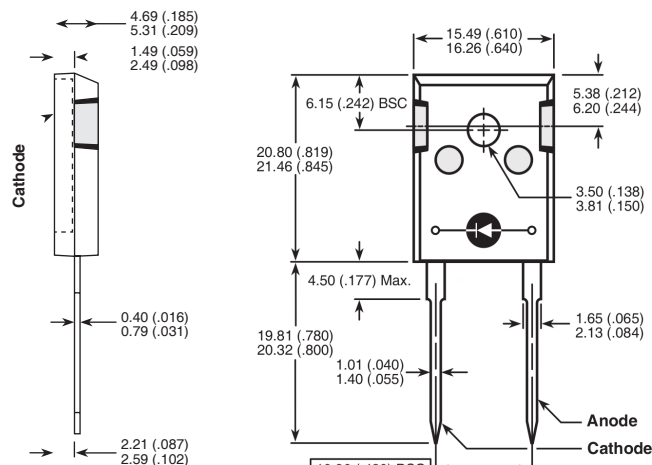


Figure 10. Diode Reverse Recovery Waveform and Definitions

TO-247 Package Outline



Dimensions in Millimeters and (Inches)



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